

# Search Notes



Application/Control No.

10/824,756

Examiner

Pablo N. Tran

Applicant(s)/Patent under  
Reexamination

KARSTENS ET AL.

Art Unit

2618

## SEARCHED

Class	Subclass	Date	Examiner
455	550.1	02/27/06	pd
	556.1		
	556.2		
	557		
	90.1		
	575.1		
	90.3		
	558		
	344-746		
	41.2		
	412-420		
375	220-221		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR